

Electronic Supporting Information to accompany:

Understanding Material Characteristics through Signature Traits from Helium Pycnometry

Huong Giang T. Nguyen,^{a*} Jarod C. Horn,^a Matthew Bleakney,^a Daniel Siderius,^a and Laura Espinal^{a*}

^aNational Institute of Standards and Technology, 100 Bureau Drive Gaithersburg, Maryland 20899, United States

Table of Contents

Cover sheet	S1
Figure S1. Powder X-Ray diffraction pattern for MIL-53 LT and its simulated pattern.	S2

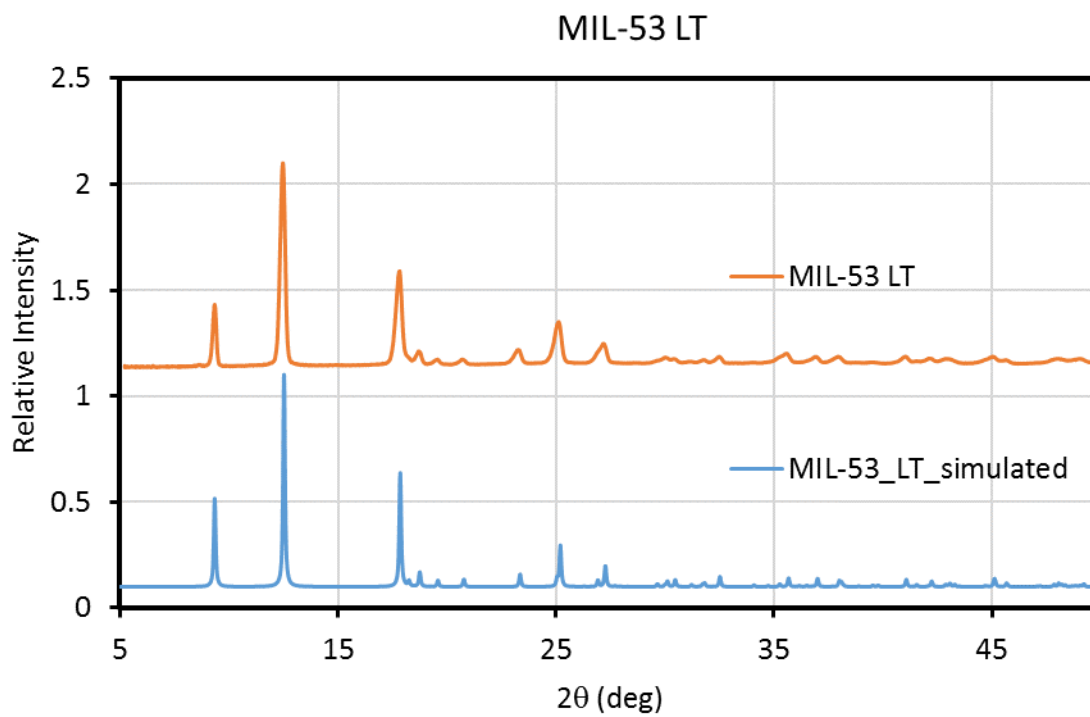


Figure S1. Powder X-Ray diffraction pattern for MIL-53 LT and its simulated pattern.